



#### P-CHANNEL ENHANCEMENT MODE MOSFET

### **Product Summary**

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> max	I <sub>D</sub> max T <sub>A</sub> = 25°C
201/	$50m\Omega$ @ $V_{GS} = -10V$	-4.5A
-30V	90mΩ @ V <sub>GS</sub> = -4.5V	-3.5A

### **Description**

This MOSFET has been designed to minimize the on-state resistance  $(R_{DS(on)})$  and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

### **Applications**

- Backlighting
- Power Management Functions
- DC-DC Converters

### **Features**

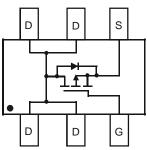
- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 standards for High Reliability

### **Mechanical Data**

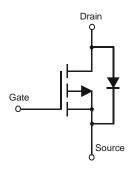
- Case: TSOT26
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections Indicator: See diagram
- Terminals: Finish Matte Tin annealed over Copper leadframe.
   Solderable per MIL-STD-202, Method 208 63
- Weight: 0.013grams (approximate)







Device Schematic



**Equivalent Circuit** 

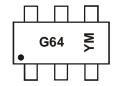
### Ordering Information (Note 4)

Part Number	Case	Packaging
DMP3050LVT-7	TSOT26	3000/Tape & Reel

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com.

## **Marking Information**



G64 = Product Type Marking Code YM = Date Code Marking Y = Year (ex: Y = 2011)

M = Month (ex: 9 = September)

Date Code Key

Year	201	1	2012		2013	20	14	2015		2016	2	2017
Code	Υ		Z		Α	E	3	С		D		Е
Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	N	D



# Maximum Ratings (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic		Symbol	Value	Units	
Drain-Source Voltage	$V_{DSS}$	-30	V		
Gate-Source Voltage (Note 5)	$V_{GSS}$	±25	V		
Continuous Prais Current (Note 6) // 40)/	Steady State	$T_A = +25$ °C $T_A = +70$ °C	I <sub>D</sub>	-4.5 -3.5	А
Continuous Drain Current (Note 6) V <sub>GS</sub> = -10V	t<10s	$T_A = +25$ °C $T_A = +70$ °C	I <sub>D</sub>	-5.2 -4.1	А
Maximum Continuous Body Diode Forward Current	I <sub>S</sub>	-2	Α		
Pulsed Drain Current (10μs pulse, duty cycle = 1%)	I <sub>DM</sub>	-30	Α		

# Thermal Characteristics (@TA = +25°C, unless otherwise specified.)

Characteristic		Symbol	Value	Units
Total Power Dissipation (Note 6)	$T_A = +25$ °C	D	1.8	W
Total Power Dissipation (Note 6)	$T_A = +70$ °C	P <sub>D</sub>	1.1	VV
Thermal Resistance, Junction to Ambient (Note 6)	Steady State	В	72	
Thermal Resistance, Junction to Ambient (Note 0)	t<10s	$R_{\theta JA}$	51	°C/W
Thermal Resistance, Junction to Case (Note 6)	Steady State	$R_{ heta JC}$	24	
Operating and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	°C

# Electrical Characteristics (@T<sub>A</sub> = +25°C, unless otherwise specified.)

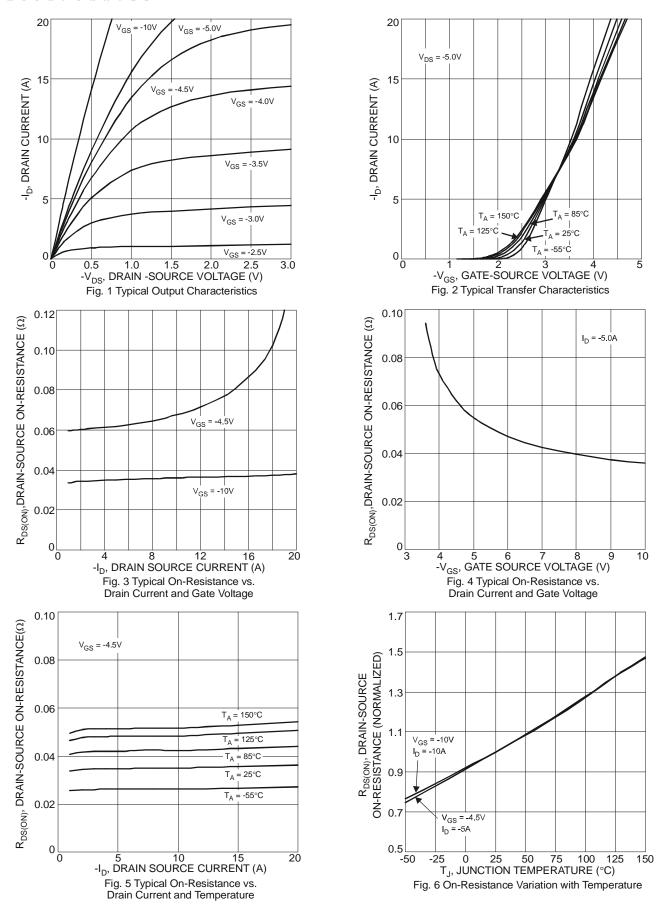
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 7)	, ,		71			
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	-30	-	-	V	$V_{GS} = 0V, I_D = -250\mu A$
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	-	-	-1	μA	$V_{DS} = -30V, V_{GS} = 0V$
Gate-Source Leakage	I <sub>GSS</sub>	-	-	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 7)						
Gate Threshold Voltage	$V_{GS(th)}$	-1.0	-	-2.0	V	$V_{DS} = V_{GS}$ , $I_D = -250\mu A$
Static Drain-Source On-Resistance		-	38	50	mΩ	$V_{GS} = -10V, I_D = -4.5A$
Static Dialii-Source Off-Nesistance	R <sub>DS</sub> (ON)	-	65	90	111 44	$V_{GS} = -4.5V, I_D = -3A$
Forward Transfer Admittance	Y <sub>fs</sub>	-	7.2	-	S	$V_{DS} = -5V, I_{D} = -5A$
Diode Forward Voltage	$V_{SD}$	-	-0.7	-1.0	V	$V_{GS} = 0V, I_{S} = -1A$
DYNAMIC CHARACTERISTICS (Note 8)						
Input Capacitance	Ciss	-	620	-	pF	15,4,3,4,0,4
Output Capacitance	Coss		83	-	рF	$V_{DS} = -15V, V_{GS} = 0V,$ of = 1.0MHz
Reverse Transfer Capacitance	C <sub>rss</sub>	-	62	-	pF	1 = 1.000112
Gate resistance	$R_g$	-	10.8	-	Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1.0MHz$
Total Gate Charge (V <sub>GS</sub> = 4.5V)	$Q_g$	-	5.1	-	nC	
Total Gate Charge (V <sub>GS</sub> = 10V)	$Q_g$	-	10.5	-	nC	\/ 45\/ 1 CA
Gate-Source Charge	$Q_{gs}$	-	1.8	-	nC	$V_{DS} = -15V, I_{D} = -6A$
Gate-Drain Charge	$Q_{gd}$	-	1.9	-	nC	
Turn-On Delay Time	t <sub>D(on)</sub>	-	6.8	-	ns	
Turn-On Rise Time	t <sub>r</sub>	-	4.9	-	ns	$V_{DD} = -15V, V_{GS} = -10V,$
Turn-Off Delay Time	t <sub>D(off)</sub>	-	28.4	-	ns	$R_G = 6\Omega$ , $I_D = -1A$
Turn-Off Fall Time	t <sub>f</sub>	-	12.4	-	ns	]

5. AEC-Q101 V<sub>GS</sub> maximum is ±20V

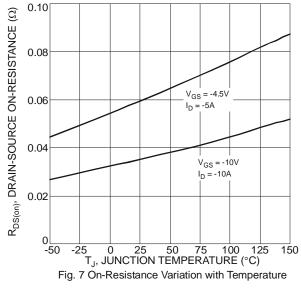
<sup>6.</sup> Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.

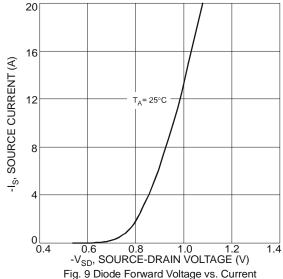
<sup>7.</sup> Short duration pulse test used to minimize self-heating effect.
8. Guaranteed by design. Not subject to product testing.

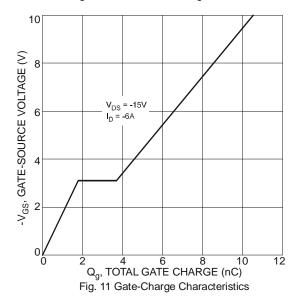












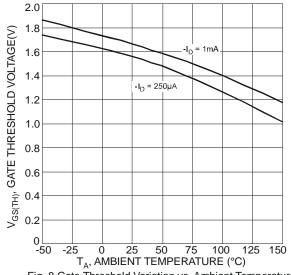
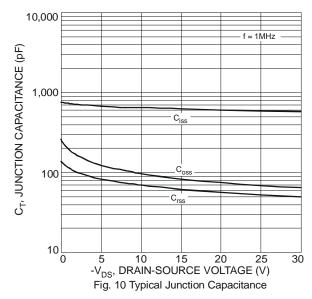


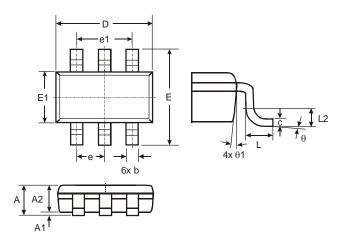
Fig. 8 Gate Threshold Variation vs. Ambient Temperature





## **Package Outline Dimensions**

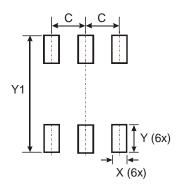
Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for latest version.



TSOT26							
Dim	Min	Max	Тур				
Α	_	1.00	1				
A1	0.01	0.10	-				
A2	0.84	0.90	1				
D	_	-	2.90				
Е	_	_	2.80				
E1	_	-	1.60				
b	0.30	0.45	1				
C	0.12	0.20	-				
е	_	-	0.95				
e1	_	_	1.90				
L	0.30	0.50					
L2	-	_	0.25				
θ	0°	8°	4°				
θ1	4°	12°	_				
All D	All Dimensions in mm						

## **Suggested Pad Layout**

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



Dimensions	Value (in mm)
С	0.950
Х	0.700
Y	1.000
Y1	3.199



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